

## Combination of surface plasmon resonance and X-ray absorption spectroscopy: SPR-XAS setup

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### Abstract

We present an experimental system to combine surface plasmon resonance and X-ray absorption spectroscopy: SPR-XAS setup [1,2]. The system allows the study of the interaction between electromagnetic radiation and matter using one type of radiation to modify the material and the other one as a probe, performing the study in real time and *in situ*. The surface plasmons, measured under the Kretschmann-Raether configuration [3], can be used to monitor *in situ* changes induced by the X-rays in the metallic film, the substrate and the top dielectric medium [4,5]. Similarly, the changes in the electronic configuration of the material when surface plasmons are excited can be measured by X-ray absorption spectroscopy [1]. The resolution of the system allows observing changes in the signals of the order of  $10^{-3}$  to  $10^{-5}$  depending on the particular experiment and used configuration. The device has been mounted at the SpLine BM25 beamline at ESRF in Grenoble, France, and it is currently available for experiments.

### References

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